Dual Polarization Stacked Microstrip Patch Antenna Array With Very Low Cross-Polarization

Granholm, Johan; Woelders, Kim

Published in:
I E E E Transactions on Antennas and Propagation

Link to article, DOI:
10.1109/8.954928

Publication date:
2001

Document Version
Publisher's PDF, also known as Version of record

Link back to DTU Orbit

Citation (APA):
Dual Polarization Stacked Microstrip Patch Antenna Array With Very Low Cross-Polarization

Johan Granholm, Member, IEEE, and Kim Woelders

Abstract—This paper describes the development and performance of a wideband dual linear polarization microstrip antenna array used in the Danish high-resolution airborne multifrequency polarimetric synthetic aperture radar, EMISAR. The antenna was designed for an operating frequency of 1.25 GHz ± 50 MHz and was built as an array of 8 × 2 probe-fed stacked microstrip patches. The bandwidth required for either C-band or L-band operation. The later addition of antennas steered to 0 Doppler, but the pod of this small electrical size—allowing only two elements to be used in the elevation dimension. The specifications are summarized in Table I.

II. ARRAY GEOMETRY, MECHANICAL AND ELECTRICAL REQUIREMENTS

The physical size of the L-band antenna array was limited by the available space in the existing aircraft pod, 1.3 × 0.31 × 0.15 m (L × H × D). This aperture size supports an array with 8 × 2 elements, spaced ≈ 0.7 λo apart. The bandwidth required of the L-band SAR was 100 MHz, to obtain a range resolution of 2 m with low range sidelobes. The operating frequency was chosen to be 1.2 to 1.3 GHz to comply with international frequency allocation regulations.

Present polarimetric SAR applications do not require cross-polarization suppression in the processed image better than 30 dB [5]. If, however, an antenna with cross-polarization suppression of e.g., 20 dB is used in a polarimetric SAR system, it is necessary in the SAR processing to correct for the antenna cross-polarization. This correction can potentially be done using distributed targets in the images [6]. A SAR scene cannot generally be expected to contain distributed targets suitable for such polarization calibration. It was, therefore, a requirement for the design described here that the cross-polarization suppression in the L-band array should be at least 30 dB.

Further specifications on the antenna array were given implicitly in terms of the maximum allowed azimuth- and left/right ambiguity of the SAR system, and also multipath suppression due to aircraft wing reflections was considered [7]. The power handling requirement was 6 kW peak input power at 45 000 ft altitude, unpressurized. In principle, the elevation pattern of the array was desired to approximate a modified cosecant-squared pattern [8], but this requirement cannot be fulfilled by an array of this small electrical size—allowing only two elements to be used in the elevation dimension. The specifications are summarized in Table I.

III. THE RADIATING ELEMENT (SELECTION OF RADIATOR AND FEEDING ARRANGEMENT)

Several radiating element candidates exist which can comply with the above requirements. In array applications it is typically necessary to use elements that can be spaced approximately 0.7 λo apart. The microstrip patch element meets this criteria. Besides the simple mechanical construction, allowing rapid in-house fabrication, microstrip patches are attractive in terms of their relatively high element directivity and their low profile and weight.

To achieve cross-polarization suppression on the order of 30 dB it is important to avoid uncontrolled radiation, e.g., from the feed network. This precludes the use of coplanar-fed and proximity-coupled patches. Aperture-coupled patches suffer from excessive back radiation, which can be prevented only using a stripline feeding network or some potentially complicated backing structure. Probe-fed patch elements can be fed using a simple unshielded microstrip feeding network located on the rear of the patch ground plane and, therefore, do not suffer from the above-mentioned disadvantages. Furthermore, if employing a partly empirical approach for the design of the
radiating patch, the number of variables in a probe fed patch design (e.g., patch size, substrate thickness, feed-offset) are fewer than in an aperture-coupled patch and simpler to vary too. Because of the good performance obtained from the previously developed dual polarization C-band microstrip antenna array [9] it was decided, that the L-band antenna should also be constructed as a probe-fed microstrip patch array.

One major difference between the C-band and the L-band antenna arrays is the 8% relative bandwidth required at L-band compared to only 2% at C-band. The 8% bandwidth requirement is quite large for a simple microstrip patch. After initial measurements on L-band microstrip patches it became evident, that a single microstrip patch could not obtain the required 8% impedance bandwidth (the bandwidth over which the antenna element can be matched to the feedline to some level, e.g., $S_{11}$ better than $-14$ dB). In order to increase the impedance bandwidth of the single patch a parasitic element was added, and in this way a broadband “stagger-tuned” (dual resonance) patch was obtained. Parasitic elements may be added to microstrip patches in various ways. In this application the obvious choice was to employ a stacked-patch solution, see Fig. 1.

The lower patch is driven by the probe(s) and the upper patch is the passive parasitic element. Due to the single-frequency dual linear polarization requirement, the stacked microstrip patch is constructed as a pair of quadratic patches. When the patch is fed on the center lines as shown in Fig. 1 the resonant frequencies are identical for the H and V polarizations.

IV. DESIGN OF THE STACKED PATCH RADIATING ELEMENT

Several stacked microstrip patch antenna designs have been reported in the literature, the majority being empirically based. Parametric studies have been reported [10], [11], aimed at determining the variables in single polarization stacked patch configurations (i.e., patch side length, substrate thickness and feed-offset) to meet specific requirements, but the different “optimum stacked patch designs” given in the literature do not agree very well. The amount of coupling between the ports of the basic radiating element (i.e., the scattering parameter $S_{21}$) will affect the cross-polarization performance of the overall array. A dual-polarization array with low $S_{21}$, requires that $S_{21}$ of the individual element is reasonably low (preferably $\leq -25$ dB). In the literature information on $S_{21}$ of dual polarization stacked patches is very scarce; the issue of achieving low $S_{21}$ in a dual polarization stacked microstrip patch elements seems not to have been addressed at all.

A series of 45 dual polarization probe-fed stacked microstrip patches having different side lengths, substrate thickness and probe feeding point offsets were fabricated and measured in order to empirically develop the basic radiating element to be used in the L-band array. The patches were mounted on a 3-mm-thick groundplane as shown in Fig. 1. The patches were fed using a SMA connector having an extended PTFE dielectric of 4.1 mm in diameter and inner conductor diameter of 1.3-mm, thus, forming a 50 $\Omega$ coaxial transmission line through the groundplane and the feeding probe.

Two-port $S$-parameters of all patches were measured on a vector network analyzer (NWA). The measurement reference plane at both ports was moved from the connector (i.e., the calibration reference plane) to the patch groundplane, using the
“port extension” feature of the NWA. For this purpose an offset short, as shown in Fig. 2, was used (a SMA-connector forms a 50 Ω transmission line through a 3 mm thick groundplane and is shorted at the end of the transmission line).

The starting point in the measurement series was to use a single patch being resonant at 1.25 GHz. The resonant frequency is in this context defined as the frequency where the real-part of the patch input impedance achieves its maximum. In order to identify the stacked patch element with the largest impedance bandwidth, a Smith chart was used to display the impedance trace over the frequency range 1.2 to 1.3 GHz. The smaller the area encircled by the impedance trace, the more constant the input impedance of the element, thus, the easier to match the element to 50 Ω. In addition to observing the input impedance (S11 and S22), the magnitude of S21 was used as a figure of merit.

The stacked patch configuration finally selected had the following dimensions: Lower patch 98.5 × 98.5 mm, feeding point 27 mm from the edges, upper patch 85 × 85 mm, lower dielectric 8 mm Rohacell 31HF foam (εr = 1.08, tan δ = 0.0001@2 GHz), upper dielectric 16 mm Rohacell 31HF foam, both patches etched on 0.381 mm RT/durroid 5870 (εr = 2.33, tan δ = 0.0012@10 GHz), lower patch facing upwards (to facilitate the probe-patch solder-joint), upper patch facing downwards (i.e., inverted), thus, making the upper dielectric act as a protective cover. The layers were assembled using 0.1 mm thick 3M type 665 adhesive film. The measured input reflection coefficients S11 and S22, (M4 on plots) and the transmission S21 between the ports of the element is shown in Fig. 3 (the reference impedance is 50 Ω).

The input impedance is reasonably constant from 1.2 to 1.3 GHz. Over this frequency range the real part of the impedance varies between 29 Ω to 33 Ω and the imaginary part from 51 Ω to 57 Ω. The input reflection coefficient (S11 and S22) of the unmatched element is ≈ −5 dB. The transmission between the ports of the element (S21) is almost constant at −25 dB.

SAR system considerations specify a minus space of 167 mm in the azimuth and 135 mm in the elevation direction (0.70 λ0 and 0.56 λ0) [12]. In order to assess the level of mutual coupling, a 2 × 2 element array with these element spacings was built. The mutual coupling between different elements and polarizations in the 2 × 2 element group was measured. It was found that the strongest mutual coupling in the 2 × 2 element group (of unmatched elements) appeared in the E-plane for the V polarization. The level was approximately −17 dB. For the H-polarization the E-plane coupling was approximately −20 dB. The cross-polarization coupling between adjacent elements was below −25 dB. Due to these fairly low values, the effect of mutual coupling was not taken into account in the design of the array.

The radiation pattern of the selected stacked patch element was measured in the spherical near-field test facility at EMI [13]. The reference-element radiation pattern, shown in Fig. 4, was used for the pattern calculations during the subsequent design of the 8 × 2 element array.

The pattern is clearly asymmetrical due to the probe feeding. Within the mainlobe the cross-polarization level is on the order of −25 dB. The peak directivity is 9 dBi. The copolar radiation pattern was found to be practically constant over the 1.2 to 1.3 GHz frequency range.

It was desired to match the individual elements to a 50 Ω level and combine the elements into groups at the 50 Ω level. An impedance matching network was designed in microstrip on a 1.52 mm thick Rogers RO3003 dielectric substrate (εr = 3.00, tan δ = 0.0013@10 GHz) to match the patch to the 50 Ω level over the 1.2 to 1.3 GHz frequency range. In Fig. 5(a) the measured S-parameters are shown for the dual polarization patches. The patch matching network layout (one connected to each feeding probe) is shown in Fig. 5(b); the position of the probe is indicated by a small dot.

The return-loss (upper graph) is below −28 dB over the frequency range 1.2 to 1.3 GHz but S21 (lower graph) has now increased from −25 dB (for the “naked” element) to −23 dB due to the improved matching.

V. “PRIOR” CROSS-POLARIZATION SUPPRESSION TECHNIQUE

An array constructed of identically oriented and -fed dual polarization antenna elements has the same cross-polarization level as the individual elements. This level can be improved by using pairwise mirrored elements as shown in Fig. 6(a) and feeding the H ports of two adjacent mirrored patches 180º out of phase, while feeding the V ports in phase, as was done in the dual polarization antenna for the C-band SAR [9].
Fig. 4. Measured co- and cross-polarization radiation pattern for the stacked microstrip patch ($f = 1.20, 1.25, \text{ and } 1.30 \text{ GHz}$).

Fig. 5. Measured S-parameters for the dual polarization patch including patch matching networks and layout of microstrip matching network.

In the figure "+1" and "-1" are the complex element excitations. In Fig. 6(a) the surface currents on the patches near the driven probes and the copolar electrical fields are indicated for feeding at the H-ports. The copolar fields from the patches will add in phase toward boresight. The cross-polarization will be significantly improved in the elevation plane. When fed on the...
H-ports, the cross-polarization of the two-element pair in the elevation plane consists to a first approximation of the contributions from the probes and from the signals that leak through the elements to the V-ports (due to nonzero S_{21} of the individual elements). Both cross-polar contributions will cancel because the two H-ports are fed 180° out of phase. When fed on the V-ports, the cross-polarization of the two-mirrored element pair in the elevation plane consists primarily of the contributions from the signals that leak through the elements to the H-ports (the V-probe fields are copolar in the elevation plane). These cross-polarization field contributions will cancel due to the opposite locations of the H-port feeding points.

With proper design of the feeding network for the two-mirrored element pair, the transmission S_{21} between the input ports of the two-mirrored element pair vanishes, regardless of the value of S_{21} of the individual element. The mirrored pair feeding technique has been used to reduce S_{21} of coplanar-fed dual polarization microstrip patch arrays, [14].

The calculated radiation pattern of a four-element group constructed of two-mirrored element pairs [Fig. 6(b)] is shown in Fig. 7. The element spacing in all 2 × 2 element groups considered below is 0.70 \lambda_0 \times 0.56 \lambda_0.

The cross-polarization of this group is significantly improved compared to that of the individual element (the radiation pattern shown in Fig. 4). Note that this feeding method causes a "missing null" (at $\theta = \pm 45^\circ$) in the azimuth plane radiation pattern for the horizontal polarization of the four-element group constructed as two mirrored element pairs. This missing null will result in grating lobes in arrays employing the in Fig. 6(a) shown two-mirrored element pairs [15], [16]. In e.g., the dual polarization C-band array [9], using these two-mirrored element pairs, grating lobes occurred in the azimuth plane for the H-polarization for $\theta = \pm 42^\circ$ only 20 dB below the main beam peak (the element spacing used in this array was 0.75 \lambda_0 \times 0.70 \lambda_0). The measured radiation pattern of the C-band array is shown in Fig. 8.

For the V polarization a pair of grating lobes occurred in the azimuth plane at the same angles, 23 dB below the main beam peak. These grating lobes are an inherent disadvantage of the "mirrored pair" feeding technique. Thus, the penalty paid for the improved cross-polarization suppression and for the improved S_{21} of the two-mirrored element pairs is the formation of the grating lobes.

VI. NEW CROSS-POLARIZATION SUPPRESSION TECHNIQUE

A new design principle which preserves the advantages of the "mirrored pair" feeding technique (improved cross-polarization suppression and low S_{21} of the array), while avoiding the inherent disadvantages (grating lobes) is described in [15], [16]. One property of this new principle is to restore the missing nulls of the two-mirrored element pair of Fig. 6(a), by arranging the elements and the feeding of the elements in a four-element group as shown in Fig. 9.

The four-element group consists of two two-mirrored element pairs (upper and lower). The upper element pair is as shown in Fig. 6(b), whereas the lower element pair has the individual elements swapped. The horizontal polarization excitations of the
elements in the upper and the lower element pairs must therefore be in anti-phase (indicated by “+1” and “−1”) to let the copolar signals from the elements add in phase toward boresight. The vertical polarization excitations are all in phase. Each of the two pairs (upper and lower) will feature the same good cross-polarization properties as the two-mirrored element pair shown in Fig. 6(a), and each of the pairs will also have very low $S_{21}$. The four-element group will restore the missing nulls of the horizontal polarization in the azimuth-plane radiation pattern, [16]. The calculated radiation pattern of the new four-element group is shown in Fig. 10.

The cross-polarization vanishes in the elevation plane for both the H- and the V-polarization. In the azimuth plane the cross-polarization is significantly suppressed, particularly for the H-polarization. Note that the nulls in the H-polarization azimuth plane are restored compared to Fig. 7.

VII. THE MICROSTRIP FEEDING NETWORK

The $8 \times 2$ element L-band antenna was designed using the new principle. To implement the element excitations, a feeding network was designed in microstrip (on 1.52-mm-thick Rogers RO3003 dielectric substrate). The microstrip network was glued onto the nonradiating side of a silver-plated aluminum groundplane using an electrically conductive (silver-filled) epoxy-based adhesive film (Ablefilm 5025E supplied by Ablestik Laboratories, Inc.). Fig. 11 shows the layout of one $2 \times 2$ element L-band panel, including the outline of the patches.

The elements within a $2 \times 2$ element panel have uniform excitations. Note that the groundplane does not extend much beyond the patch edges.

The network comprises two-way $-3\text{-dB}/0^\circ$ Wilkinson power dividers to feed the V ports (with 100 $\Omega$ high-power chip resistors glued to the 3-mm aluminum ground plane), and two-folded $-3\text{-dB}/180^\circ$ hybrids (“rat races”) to feed the H ports. The networks were designed and tested individually before being integrated into the final layout. The Wilkinson divider achieved
Fig. 10. Calculated radiation pattern of four-element group using new cross-polarization suppression technique.

Fig. 11. Microstrip layout of 2 × 2 element dual polarization L-band antenna panel (PCB size: 341 mm × 304 mm).
The vertical 50 Ω E-plane bend, cross section and one bend prototype.

Fig. 13. Patch configuration for 8 × 2 element dual polarization L-band array.

The measured input reflection coefficients (upper graph) and the transmission between the H- and V-polarization reflection coefficients (upper graph) of the 8 × 2 element dual polarization L-band antenna are shown in Fig. 15.

It is seen that the H- and the V-polarization reflection coefficients (upper graph) are below −14 dB over an 11% bandwidth. It should be mentioned, however, that the H- and V-port input reflection coefficient of the four-element groups were initially only on the order of −13 dB and −10 dB, respectively. The degradation from the very good element match (shown in Fig. 5) is believed to be caused by the neglected mutual coupling effects. To improve the matching, the network shown in Fig. 5 was tuned by soldering small pieces of copper tape (identical for all elements) to two of the matching lines. The transmission between the H- and V-ports is improved from −23 dB for the individual microstrip patch element (see Fig. 5) to approximately −50 dB for the array.

Fig. 16 shows the measured radiation pattern for the 8 × 2 element dual polarization L-band.

The measured peak directivity varies over the 1.2 to 1.3 GHz frequency range from 18.8 to 19.5 dBi for the V polarization and from 18.1 to 19.0 dBi for the H polarization. The measured loss in the antenna array is 1.5 dBi; almost the same for the two polarizations. The cross-polarization level is on the order of −35 to −40 dB in the azimuth plane and below −40 dB in the elevation plane. The asymmetry in the azimuth plane of the horizontal polarization pattern is believed to be due to minor amplitude/phase unbalances in the feeding network. The measured pattern does not have the predicted nulls in elevation for θ = ±63°. The reason is that the ground plane for the real antenna only extends 0.15 λ0 beyond the edges of the patches, causing the radiation patterns for the upper and lower patches to be perturbed in opposite directions. This is also believed to be the reason for especially the cross-polarization fields in azimuth.
being somewhat higher than predicted. The array radiation outside the $\theta = \pm 90^\circ$ region (i.e., outside the forward region of the array) was suppressed more than 45 dB, partly due to the use of probe-fed patches, partly because all the feeding networks were completely shielded.

The array has successfully been flown for 6 years as a part of the Danish high resolution multifrequency airborne SAR-system EMISAR and the mechanical construction has proved to sustain the repeated temperature cycles in the pod, from $+35^\circ$C at ground level to $-65^\circ$C at 41 000 ft altitude.
IX. CONCLUSION

The development and performance of an 8 × 2 element L-band dual linear polarization stacked wideband microstrip patch antenna array is described. The array design is based on a new cross-polarization suppression technique. Using this technique the cross-polarization level in the array is significantly suppressed compared to the cross-polarization level of the basic radiating element and no undesired side lobes occur in the radiation pattern of the array. The combination of bandwidth and radiation pattern purity obtained for this array is believed to represent state-of-the-art in probe-fed microstrip antenna arrays.

REFERENCES


Johan Granholm (M’88) photograph and biography not available at the time of publication.

Kim Woelders photograph and biography not available at the time of publication.